

Search Notes

Application/Control No.

10/669,496

Examiner

Vuthe Siek

Applicant(s)/Patent under
Reexamination

CHANG ET AL.

Art Unit

2825

SEARCHED

Class	Subclass	Date	Examiner
716	2-6,7-8	3/1/2805	VS

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST ALL DATABASES	3/28/2005	VS